Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/631,928	TEOH ET AL.	
Examiner	Art Unit	
Victor X Nauven	3734	

	SEAR	CHED	
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Class	Subclass	Date	Examiner
606	108,190	4/18/2007	VN
	194,198	āl	ч
604	104,107	и	u

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			-

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventors searched	4/18/2007	VN
Text/EAST searched	ч	<i>'</i>
Consulted with TQAS Tom Barrett	4/18/2007	ч
Consulted with Prmary Michael Thaler	4/19/2007	11
Consulted with SPE Michael Hayes	ı II	11